Search Notes

App	olication/Control No.	Applicant(s)/Patent under Reexamination
10/	813,941	LEBEDEV ET AL.
Exa	miner	Art Unit
Hei	nry K. Choe	2817

SEARCHED							
Class	Subclass	Date	Examiner				
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INT	INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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See starbut NPL (IEEE) See attarbut	"	"	
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